

MOS FIELD EFFECT TRANSISTOR 2SK3058

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

This product is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Super Low On-State Resistance $R_{DS(on)1} = 17 \text{ m}\Omega$ MAX. (Vgs = 10 V, ID = 28 A) $R_{DS(on)2} = 27 \text{ m}\Omega$ MAX. (Vgs = 4.0 V, ID = 28 A)
- Low Ciss : Ciss = 2100 pF (TYP.)
- Built-in Gate Protection Diode

ORDERING INFORMATION

PART NUMBER	PACKAGE
2SK3058	TO-220AB
2SK3058-S	TO-262
2SK3058-ZJ	TO-263
2SK3058-Z	TO-220SMD ^{Note}

Note TO-220SND package is produced only in Japan.

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage (Vgs = 0)	VDSS	60	V
Gate to Source Voltage (Vps = 0)	VGSS(AC)	±20	V
Gate to Source Voltage (Vps = 0)	VGSS(DC)	+20, -10	V
Drain Current (DC)	ID(DC)	±55	Α
Drain Current (Pulse) Note1	D(pulse)	±165	Α
Total Power Dissipation (Tc = 25°C)	PT	58	W
Total Power Dissipation (T _A = 25°C)	PT	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	T _{stg}	-55 to + 150	°C
Single Avalanche Current Note2	las	27.5	Α
Single Avalanche Energy Note2	Eas	75.6	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1 %

2. Starting Tch = 25 °C, Vdd = 30 V, Rg = 25 Ω , Vgs = 20 V \rightarrow 0



(TO-262)



(TO-263, TO-220SMD)



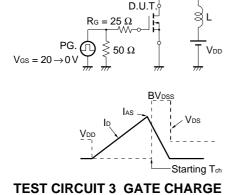
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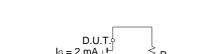
ELECTRICAL CHARACTERISTICS (TA = 25 °C)

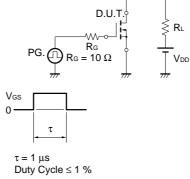
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 28 A		12	17	mΩ
	RDS(on)2	Vgs = 4.0 V, Ip = 28 A		19	27	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0	1.6	2.0	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 28 A	13	42		S
Drain Leakage Current	IDSS	Vps = 60 V, Vgs = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	VGS = ±20 V, VDS = 0 V			±10	μΑ
Input Capacitance	Ciss	V _{DS} = 10 V		2100		pF
Output Capacitance	Coss	V _G S = 0 V		550		pF
Reverse Transfer Capacitance	Crss	F = 1 MHz		220		pF
Turn-on Delay Time	td(on)	ID = 28 A		36		ns
Rise Time	tr	Vgs = 10 V		410		ns
Turn-off Delay Time	td(off)	V _{DD} = 30 V		130		ns
Fall Time	tf	R _G = 10 Ω		260		ns
Total Gate Charge	QG	ID = 55 A		45		nC
Gate to Source Charge	Qgs	V _{DD} = 48 V		7		nC
Gate to Drain Charge	Q _{GD}	V _G S = 10 V		13		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 55 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 55 A, VGS = 0 V		60		ns
Reverse Recovery Charge	Qrr	di/dt = 100A/μs		100		nC

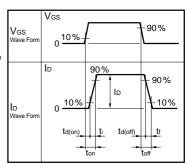
TEST CIRCUIT 1 AVALANCHE CAPABILITY

* TEST CIRCUIT 2 SWITCHING TIME

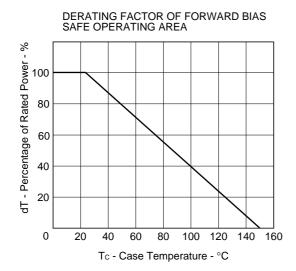


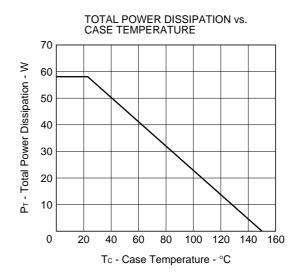




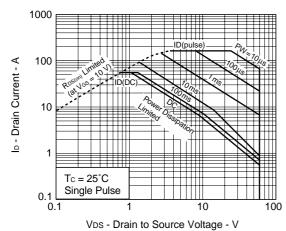


TYPICAL CHARACTERISTICS (TA = 25 °C)

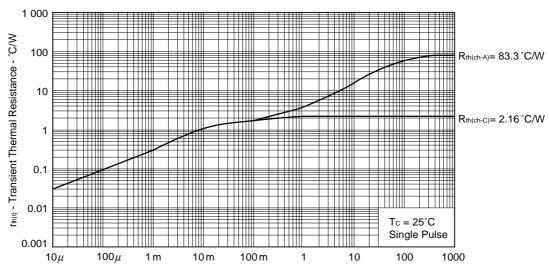




FORWARD BIAS SAFE OPERATING AREA

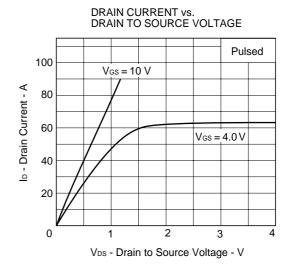


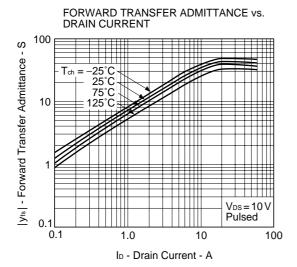
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



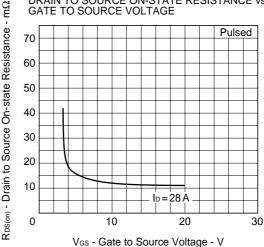
PW - Pulse Width - s

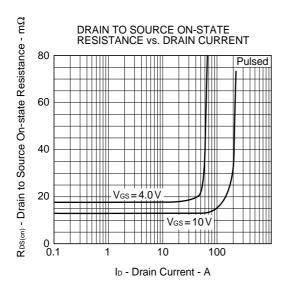
FORWARD TRANSFER CHARACTERISTICS 100 Ip - Drain Current - A 10 125°C 75°C 25°C -25°C 1 0.1 Pulsed 0 4 Vgs - Gate to Source Voltage - V



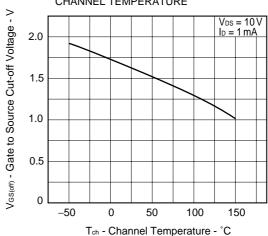


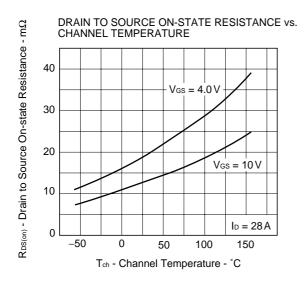


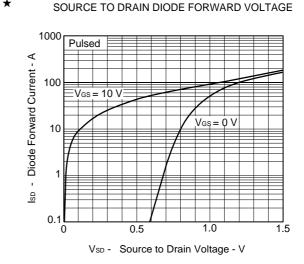


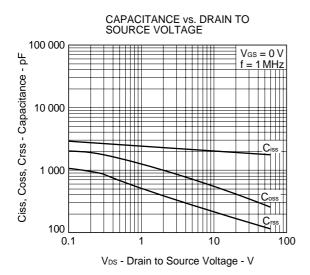


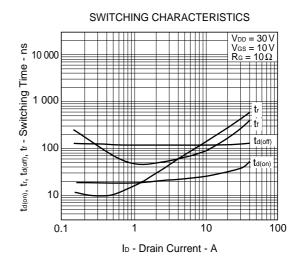


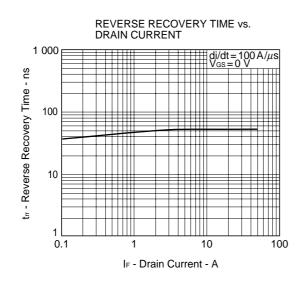


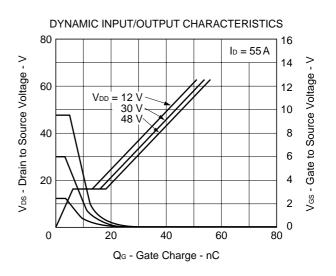




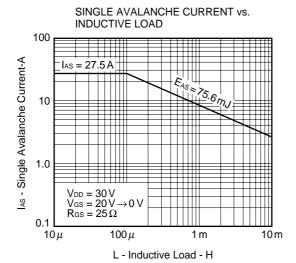




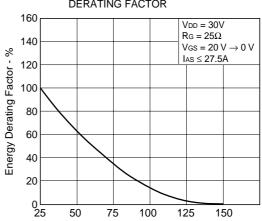




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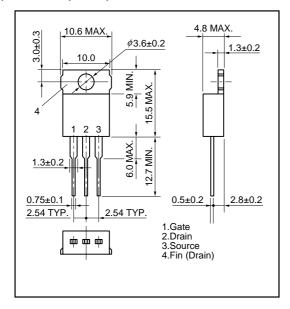
SINGLE AVALANCHE ENERGY DERATING FACTOR



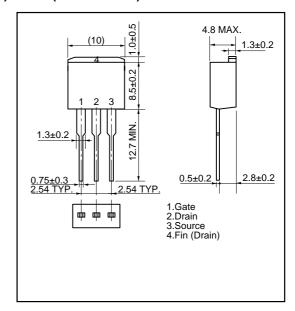
Starting Tch - Starting Channel Temperature - °C

PACKAGE DRAWINGS (Unit: mm)

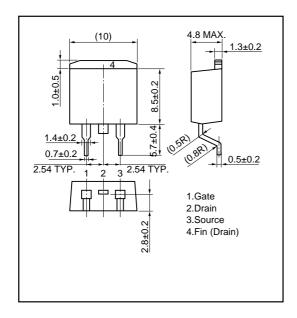
1)TO-220AB (MP-25)



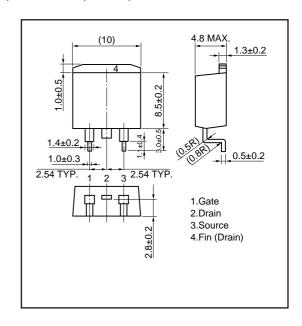
2)TO-262 (MP-25 Fin Cut)



3)TO-263 (MP-25ZJ)

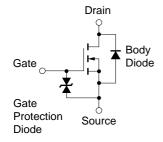


★ 3)TO-220SMD (MP-25Z)^{Note}



EQUIVALENT CIRCUIT

Note This package is produced only in Jaman.



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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